

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/565,676	IIZUKA, HACHISHIRO	
Examiner	Art Unit		Page 1 of 1
Keath T. Chen	1709		

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*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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